Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/697,558	HAYASHI ET AL.
	Examiner	Art Unit
	Sophia S. Chen	2852

SEARCHED

Class	Subclass	Date	Examiner
399	258	3/22/2005	SC
	262		
	260		
	120		
	119		
222	DIG.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES
(INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Text Search (see printout)	3/22/2005	SC

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